



BAS70W/ -04/ -05/ -06

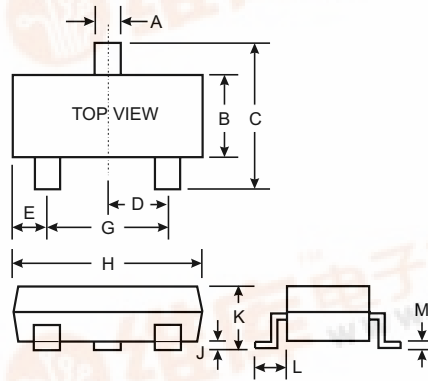
SURFACE MOUNT SCHOTTKY BARRIER DIODE

Features

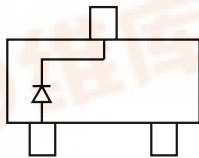
- Low Turn-on Voltage
- Fast Switching
- PN Junction Guard Ring for Transient and ESD Protection
- Ultra-Small Surface Mount Package

Mechanical Data

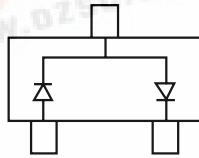
- Case: SOT-323, Molded Plastic
- Terminals: Solderable per MIL-STD-202, Method 208
- Polarity: See Diagrams
- Marking: See Diagrams
- Mounting Position: Any
- Approx. Weight: 0.006 grams



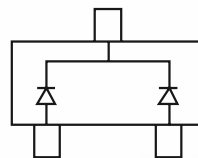
SOT-323		
Dim	Min	Max
A	0.30	0.40
B	1.15	1.35
C	2.00	2.20
D	0.65 Nominal	
E	0.30	0.40
G	1.20	1.40
H	1.80	2.20
J	0.0	0.10
K	0.90	1.00
L	0.25	0.40
M	0.10	0.25
All Dimensions in mm		



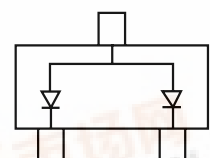
BAS70W Marking: K73



BAS70W-04 Marking: K74



BAS70W-05 Marking: K75



BAS70W-06 Marking: K76

Maximum Ratings and Electrical Characteristics, Single Diode @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	BAS70W	Unit
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	V_{RRM} V_{RWM} V_R	70	V
RMS Reverse Voltage	$V_{R(RMS)}$	49	V
Forward Continuous Current (Note 1)	I_F	70	mA
Non-Repetitive Peak Forward Surge Current @ $t_p < 1.0\text{s}$	I_{FSM}	100	mA
Power Dissipation (Note 1)	P_d	200	mW
Thermal Resistance Junction to Ambient Air (Note 1)	$R_{\theta JA}$	625	K/W
Operating Junction Temperature Range	T_j	-55 to +125	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-65 to +150	$^\circ\text{C}$

Electrical Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Min	Max	Unit	Test Condition
Reverse Breakdown Voltage (Note 2)	$V_{(BR)R}$	70	—	—	$I_R = 10\mu\text{A}$
Forward Voltage	V_{FM}	—	410 1000	mV	$t_p < 300\mu\text{s}$, $I_F = 1.0\text{mA}$ $t_p < 300\mu\text{s}$, $I_F = 15\text{mA}$
Peak Reverse Current	I_{RM}	—	100	nA	$t_p < 300\mu\text{s}$, $V_R = 50\text{V}$
Junction Capacitance	C_j	—	2.0	pF	$V_R = 0\text{V}$, $f = 1.0\text{MHz}$
Reverse Recovery Time	t_{rr}	—	5.0	ns	$I_F = I_R = 10\text{mA}$ to $I_R = 1.0\text{mA}$, $I_{rr} = 0.1 \times I_R$, $R_L = 100\Omega$

Notes: 1. Valid provided that terminals are kept at ambient temperature.

2. Test period $< 3000\mu\text{s}$.

